

DATASHEET 规格书

SISD0600ED120i20

ED-Type phase leg IGBT module

ED 封装半桥 IGBT 模块



$V_{CE} = 1200\text{ V}$
 $I_C = 2 \times 600\text{ A}$

- *i20* ultra-low loss fine pattern Trench IGBT chipset
i20 超低损耗精细沟槽栅型 IGBT 芯片组
- Baseplate isolation with efficient Al_2O_3 ceramic
高效 Al_2O_3 绝缘陶瓷基板
- Cu baseplate for low thermal resistance
低热阻铜底板
- Industry standard package
行业标准封装

Maximum ratings¹ 最大额定值¹

PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件	MIN 最小值	MAX 最大值	UNIT 单位
Collector-emitter voltage 集电极-发射极电压	V_{CES}	$V_{GE} = 0\text{ V}$, $T_{vj} = 25\text{ °C}$		1200	V
DC collector current 集电极直流电流	I_C	$T_C = 120\text{ °C}$, $T_{vj} = 175\text{ °C}$		600	A
Peak collector current 集电极峰值电流	I_{CM}	$t_p = 1\text{ ms}$		1200	A
Gate-emitter voltage 栅极-发射极驱动电压	V_{GES}		-20	20	V
Total power dissipation 最大功率损耗	P_{tot}	$T_C = 25\text{ °C}$, $T_{vj} = 175\text{ °C}$, per switch		3260	W
DC forward current 二极管直流正向电流	I_F			600	A
Peak forward current 二极管最大脉冲正向电流	I_{FRM}	$t_p = 1\text{ ms}$		1200	A
Surge current 二极管最大浪涌电流	I_{FSM} I^2t	$V_R = 0\text{ V}$, $T_{vj} = 150\text{ °C}$, $t_p = 10\text{ ms}$, half-sinewave		2750 37500	A A^2s
Isolation voltage 绝缘电压	V_{isol}	1 min, $f = 50\text{ Hz}$		3400	V
Junction operating temperature 运行结温	$T_{vj(op)}$		-40	175 ²	°C
Case temperature 壳温	T_C		-40	125 ³	°C
Storage temperature 存储温度	T_{stg}		-40	125	°C
Mounting torques 紧固力矩 ⁴	M_S	Base-heatsink, M5 screws	3	6	Nm
	M_{t1}	Main terminals, M6 screws	3	6	Nm



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¹ Maximum rated values indicate limits beyond which damage to the device may occur per IEC 60747; 根据标准 IEC 60747 要求, 最大额定值表示超过该限值可能会对器件造成损坏

² $T_{vj(op)} > 150\text{ °C}$ allowed for overload conditions, in maximum for 60s and less than 20% of operation time; 过载条件下 $T_{vj(op)} > 150\text{ °C}$ 时, 允许运行的时间不超过 60s, 或者小于运行时间的 20%

³ For UL1557 compliance T_{Cmax} must be limited to 125°C; UL1557 标准中要求, 最大壳温不能超过 125°C

⁴ For details, please refer to the mounting instructions. 详细信息, 请参考安装说明书

IGBT⁵

PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件	MIN 最小值	TYP 典型	MAX 最大值	UNIT 单位
Collector(-emitter) breakdown voltage 集电极-发射极击穿电压	$V_{(BR)CES}$	$V_{GE} = 0\text{ V}$, $I_C = 10\text{ mA}$, $T_{vj} = 25^\circ\text{C}$	1200			V
Collector-emitter saturation voltage ⁶ 集电极-发射极饱和电压	V_{CESat}	$I_C = 600\text{ A}$, $V_{GE} = 15\text{ V}$	$T_{vj} = 25^\circ\text{C}$	1.5	1.9	V
			$T_{vj} = 125^\circ\text{C}$	1.7		V
			$T_{vj} = 175^\circ\text{C}$	1.8		V
Collector cut-off current 集电极截止电流	I_{CES}	$V_{CE} = 1200\text{ V}$, $V_{GE} = 0\text{ V}$	$T_{vj} = 25^\circ\text{C}$		1	mA
			$T_{vj} = 125^\circ\text{C}$	1		mA
			$T_{vj} = 175^\circ\text{C}$	20		mA
Gate leakage current 栅极漏电流	I_{GES}	$V_{CE} = 0\text{ V}$, $V_{GE} = \pm 20\text{ V}$	-0.5		0.5	μA
Gate-emitter threshold voltage 栅极-发射极阈值电压	$V_{GE(th)}$	$I_C = 30\text{ mA}$, $V_{CE} = V_{GE}$, $T_{vj} = 25^\circ\text{C}$	5	6.2	7.5	V
Gate charge 栅极电荷	Q_G	$I_C = 600\text{ A}$, $V_{CE} = 600\text{ V}$, $V_{GE} = -15\text{ V} \dots 15\text{ V}$		5.3		μC
Input capacitance 输入电容	C_{ies}	$V_{CE} = 25\text{ V}$, $V_{GE} = 0\text{ V}$, $f = 1\text{ MHz}$, $T_{vj} = 25^\circ\text{C}$		44		nF
Output capacitance 输出电容	C_{oes}			3.9		nF
Reverse transfer capacitance 反向传输电容	C_{res}			2.1		nF
Internal gate resistor 栅极内阻	R_{Gint}	Per switch		1.2		Ω
Turn-on delay time 开通延迟	$t_{d(on)}$	$V_{CC} = 600\text{ V}$, $I_C = 600\text{ A}$, $R_G = 0.47\ \Omega$, $V_{GE} = \pm 15\text{ V}$, $L_s = 30\text{ nH}$, inductive load	$T_{vj} = 25^\circ\text{C}$	120		ns
			$T_{vj} = 125^\circ\text{C}$	145		ns
			$T_{vj} = 175^\circ\text{C}$	155		ns
Rise time 上升时间	t_r		$T_{vj} = 25^\circ\text{C}$	60		ns
			$T_{vj} = 125^\circ\text{C}$	67		ns
			$T_{vj} = 175^\circ\text{C}$	70		ns
Turn-off delay time 关断延迟	$t_{d(off)}$	$V_{CC} = 600\text{ V}$, $I_C = 600\text{ A}$, $R_G = 1.5\ \Omega$, $V_{GE} = \pm 15\text{ V}$, $L_s = 30\text{ nH}$, inductive load	$T_{vj} = 25^\circ\text{C}$	575		ns
			$T_{vj} = 125^\circ\text{C}$	685		ns
			$T_{vj} = 175^\circ\text{C}$	735		ns
Fall time 下降时间	t_f		$T_{vj} = 25^\circ\text{C}$	165		ns
			$T_{vj} = 125^\circ\text{C}$	290		ns
			$T_{vj} = 175^\circ\text{C}$	335		ns
Turn-on switching energy 开通损耗	E_{on}	$V_{CC} = 600\text{ V}$, $I_C = 600\text{ A}$, $R_G = 0.47\ \Omega$, $V_{GE} = \pm 15\text{ V}$, $L_s = 30\text{ nH}$, inductive load	$T_{vj} = 25^\circ\text{C}$	20		mJ
			$T_{vj} = 125^\circ\text{C}$	50		mJ
			$T_{vj} = 175^\circ\text{C}$	73		mJ
Turn-off switching energy 关断损耗	E_{off}	$V_{CC} = 600\text{ V}$, $I_C = 600\text{ A}$, $R_G = 1.5\ \Omega$, $V_{GE} = \pm 15\text{ V}$, $L_s = 30\text{ nH}$, inductive load	$T_{vj} = 25^\circ\text{C}$	66		mJ
			$T_{vj} = 125^\circ\text{C}$	90		mJ
			$T_{vj} = 175^\circ\text{C}$	100		mJ
Short circuit current 短路电流	I_{SC}	$t_{PCS} \leq 10\ \mu\text{s}$, $V_{GE} = 15\text{ V}$, $T_{vj} = 175^\circ\text{C}$, $V_{CC} = 800\text{ V}$, $V_{CEM\text{CHIP}} \leq 1200\text{ V}$		2000		A

⁵ Characteristic values according to IEC 60747-9

⁶ Collector-emitter saturation voltage is given at chip-level 集电极-发射极饱和电压

Diode⁷

PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件		MIN 最小值	TYP 典型	MAX 最大值	UNIT 单位
Forward voltage ⁸ 正向压降	V _F	I _F = 600 A	T _{vj} = 25 °C		1.85	2.3	V
			T _{vj} = 125 °C		1.95		V
			T _{vj} = 175 °C		2.00		V
Peak reverse recovery current 反向恢复电流峰值	I _{RM}	V _R = 600 V, I _F = 600 A, di/dt = 9000 A/μs (175 °C), R _G = 0.47 Ω, V _{GE} = ± 15 V, L _S = 30 nH, inductive load	T _{vj} = 25 °C		485		A
			T _{vj} = 125 °C		570		A
			T _{vj} = 175 °C		585		A
Recovery charge 恢复电荷	Q _{rr}		T _{vj} = 25 °C		53		μC
			T _{vj} = 125 °C		75		μC
			T _{vj} = 175 °C		133		μC
Reverse recovery time 反向恢复时间	t _{rr}		T _{vj} = 25 °C		155		ns
			T _{vj} = 125 °C		700		ns
			T _{vj} = 175 °C		840		ns
Reverse recovery energy 反向恢复能量	E _{rec}		T _{vj} = 25 °C		27		mJ
			T _{vj} = 125 °C		43		mJ
			T _{vj} = 175 °C		55		mJ

Package properties 封装特性⁹

PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件		MIN 最小值	TYP 典型	MAX 最大值	UNIT 单位
IGBT thermal resistance junction to case IGBT 结-壳热阻	R _{th(j-c)IGBT}	Per switch				0.046	K/W
Diode thermal resistance junction to case 二极管结-壳热阻	R _{th(j-c)Diode}					0.077	K/W
IGBT thermal resistance case to heatsink IGBT 壳到散热器热阻	R _{th(c-s)IGBT}	IGBT per switch			0.030		K/W
Diode thermal resistance case to heatsink 二极管壳到散热器热阻	R _{th(c-s)Diode}	diode per switch			0.036		K/W
Comparative tracking index 相对漏电起痕指数	CTI			200			
Module stray inductance 模块自身杂散电感	L _{s CE}	Per switch			20		nH
Resistance, terminal chip 端子到芯片之间的阻抗	R _{CC+EE'}	Per switch	T _{vj} = 25 °C		0.9		mΩ
			T _{vj} = 125 °C		1.25		mΩ
			T _{vj} = 175 °C		1.4		mΩ

⁷ Characteristic values according to IEC 60747-2

⁸ Forward voltage is given at chip-level 正向压降是芯片两端的电压值。

⁹ Package and mechanical properties according to IEC 60747-15



Mechanical properties 机械特性

PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件		MIN 最小值	TYP 典型	MAX 最大值	UNIT 单位
Dimensions	L x W x H	Typical		152 x 62 x 17			mm ³
Clearance distance in air 电气间隙	d _a	According to IEC 60664-1 and EN 50124-1	Terminal to base:	12.5			mm
			Terminal to terminal:	10			mm
Surface creepage distance 爬电距离	d _s	According to IEC 60664-1 and EN 50124-1	Terminal to base:	14.5			mm
			Terminal to terminal:	13			mm
Mass 重量	M				350		g

NTC Thermistor

PARAMETER 参数	SYMBOL 符号	CONDITIONS 工作条件		MIN 最小值	TYP 典型	MAX 最大值	UNIT 单位
Rated resistance 额定电阻	R ₂₅	T _c = 25 °C			5		kΩ
R100	R ₁₀₀	T _c = 100 °C		468		518	Ω
B-value B 值	B _{25/50}	$R_2 = R_{25} \exp [B_{25/50}(1/T_2 - 1/(298.15K))]$			3375		K
B-value B 值	B _{25/100}	$R_2 = R_{25} \exp [B_{25/100}(1/T_2 - 1/(298.15K))]$			3433		K

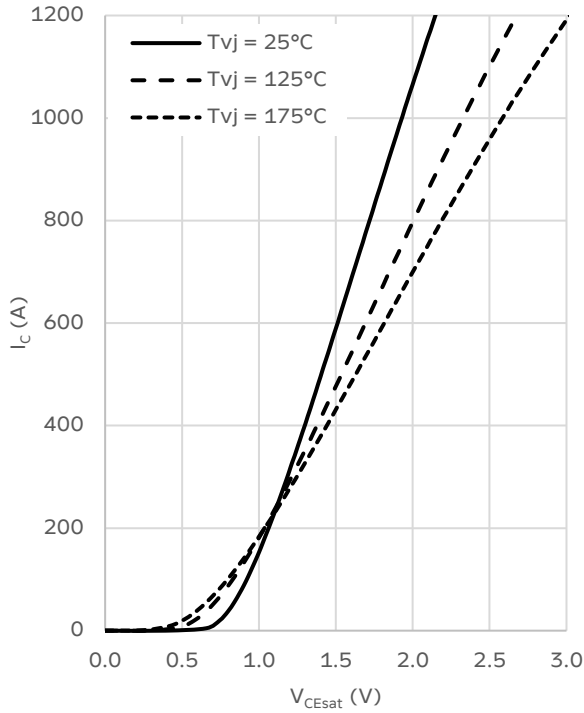


Characteristics 特性曲线

IGBT on-state characteristics (typical)

IGBT 通态特性曲线 (典型)

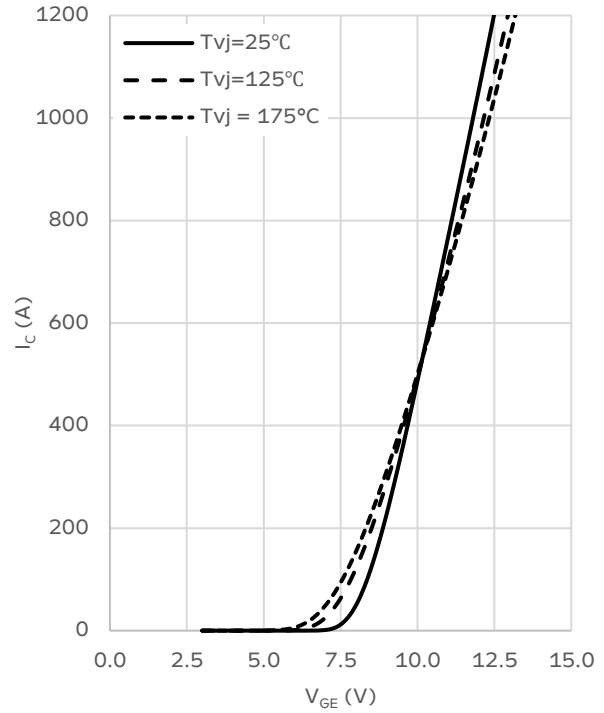
$I_C = f(V_{CE})$
 $V_{GE} = 15\text{ V}$



IGBT transfer characteristics (typical)

IGBT 转移特性曲线 (典型)

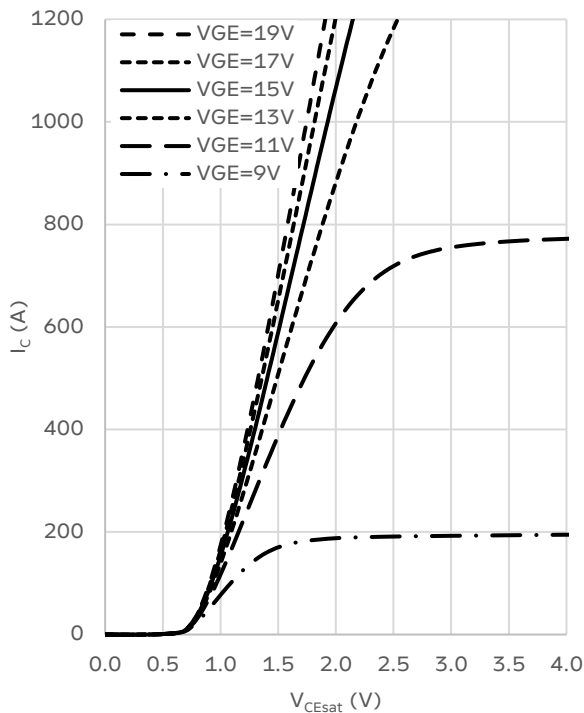
$I_C = f(V_{GE})$
 $V_{CE} = 20\text{ V}$



IGBT output characteristics (typical)

IGBT 输出特性曲线 (典型)

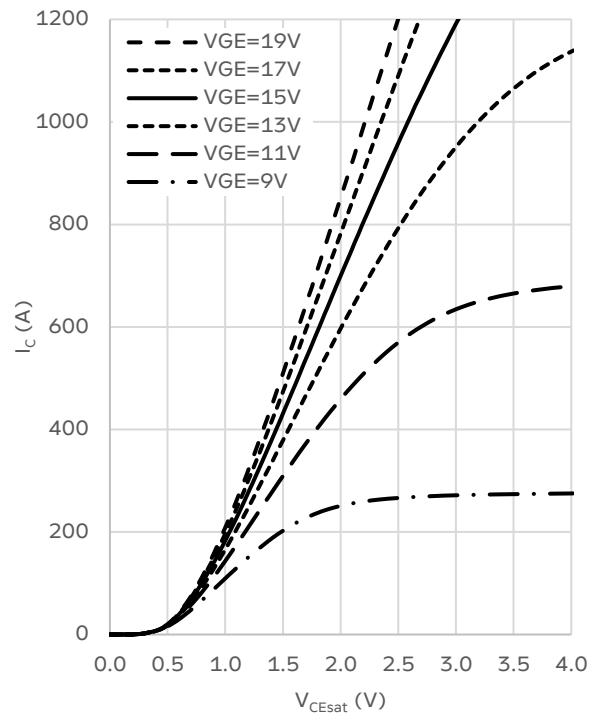
$I_C = f(V_{CE})$
 $T_{vj} = 25^\circ\text{C}$



IGBT output characteristics (typical)

IGBT 输出特性曲线 (典型)

$I_C = f(V_{CE})$
 $T_{vj} = 175^\circ\text{C}$



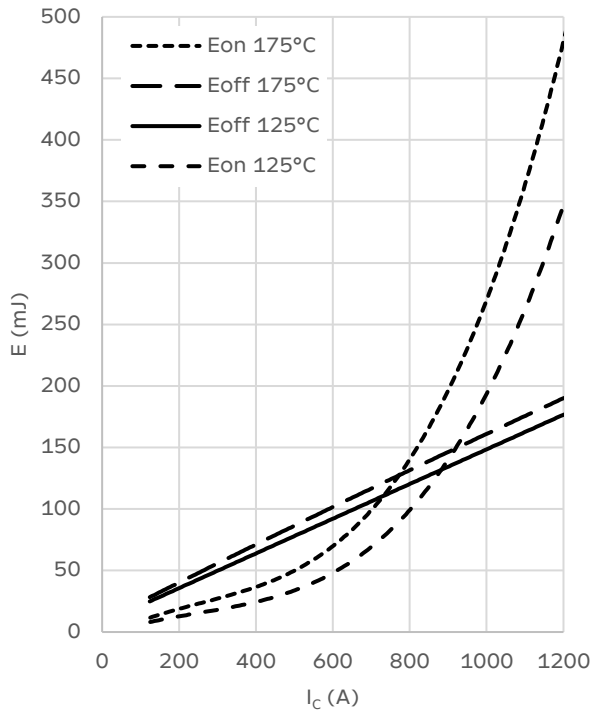


IGBT switching losses (typical)

IGBT 开关损耗曲线 (典型)

$E = f(I_{CE})$

$V_{CE} = 600\text{ V}, R_{Gon} = 0.47\ \Omega, R_{Goff} = 1.5\ \Omega, V_{GE} = -15/+15\text{ V}$

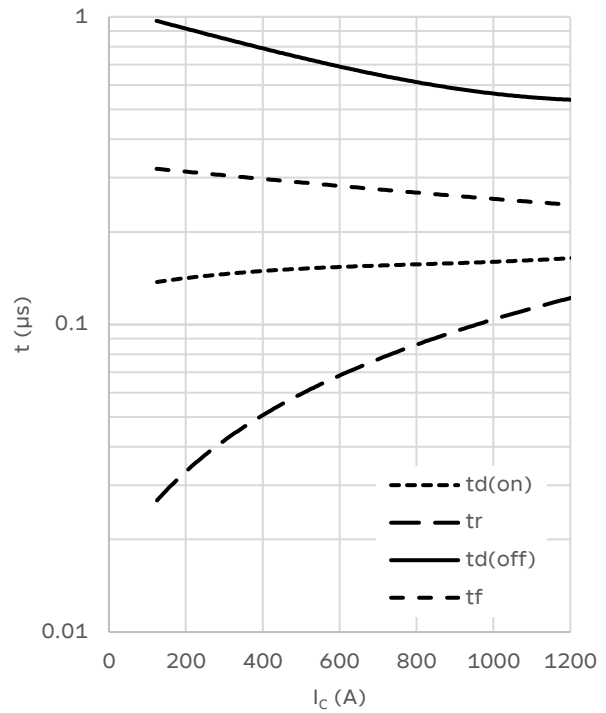


IGBT switching times (typical)

IGBT 开关时间曲线 (典型)

$t = f(I_{CE}), T_{vj} = 175\ \text{°C}$

$V_{CE} = 600\text{ V}, R_{Gon} = 0.47\ \Omega, R_{Goff} = 1.5\ \Omega, V_{GE} = -15/+15\text{ V}$

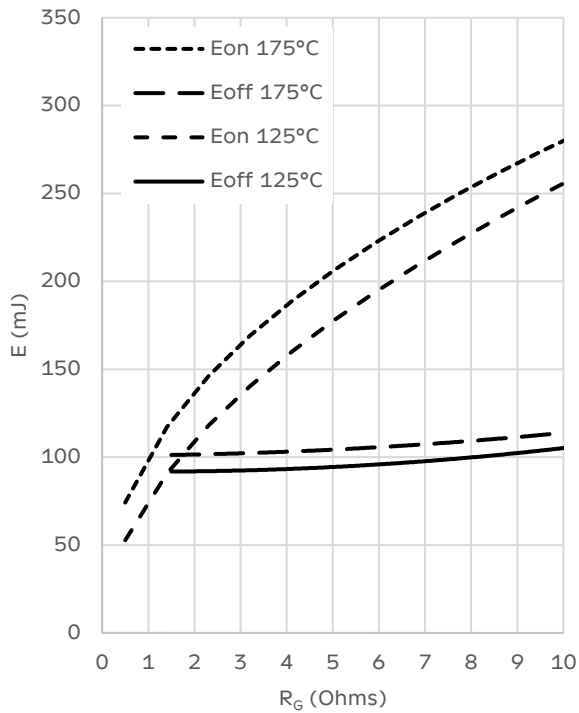


IGBT switching losses (typical)

IGBT 开关损耗曲线 (典型)

$E = f(R_G)$

$V_{CE} = 600\text{ V}, I_C = 600\text{ A}, V_{GE} = -15/+15\text{ V}$

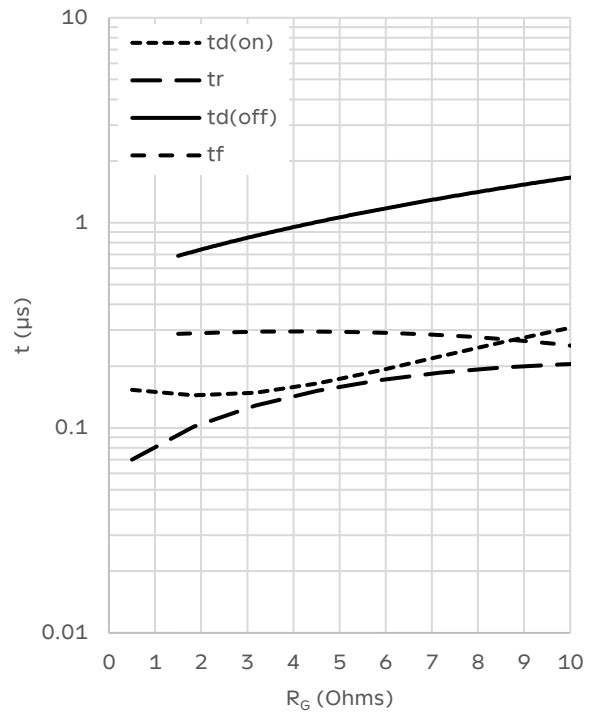


IGBT switching times (typical)

IGBT 开关时间曲线 (典型)

$t = f(R_G), T_{vj} = 175\ \text{°C}$

$V_{CE} = 600\text{ V}, I_C = 600\text{ A}, V_{GE} = -15/+15\text{ V}$



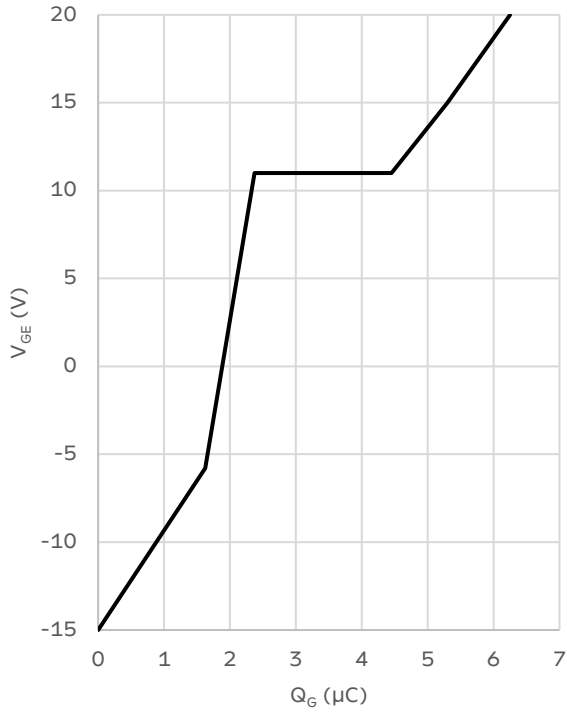


IGBT gate charge (typical)

IGBT 门极电荷 (典型)

$V_{GE} = f(Q_G), T_{vj} = 25\text{ }^\circ\text{C}$

$V_{CE} = 600\text{ V}, I_C = 600\text{ A}$

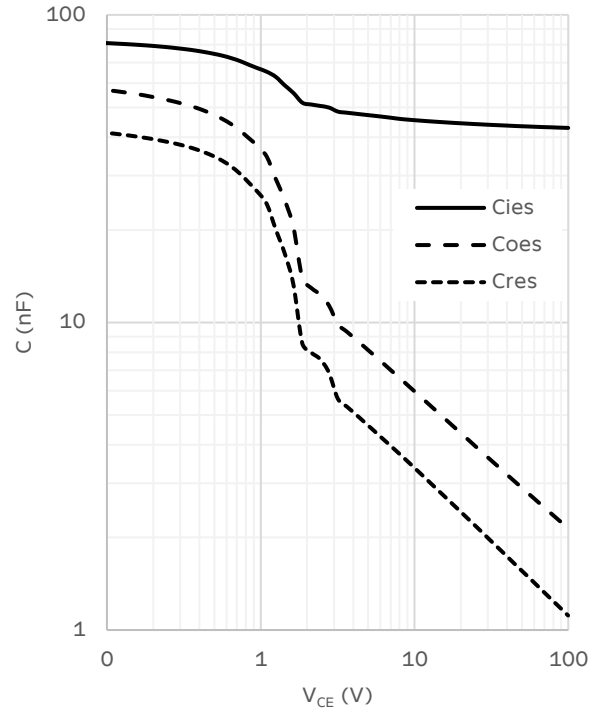


Capacitance characteristics (typical)

电容特性曲线 (典型)

$C = f(V_{CE}), T_{vj} = 25\text{ }^\circ\text{C}$

$f = 100\text{ kHz}, V_{GE} = 0\text{ V}$

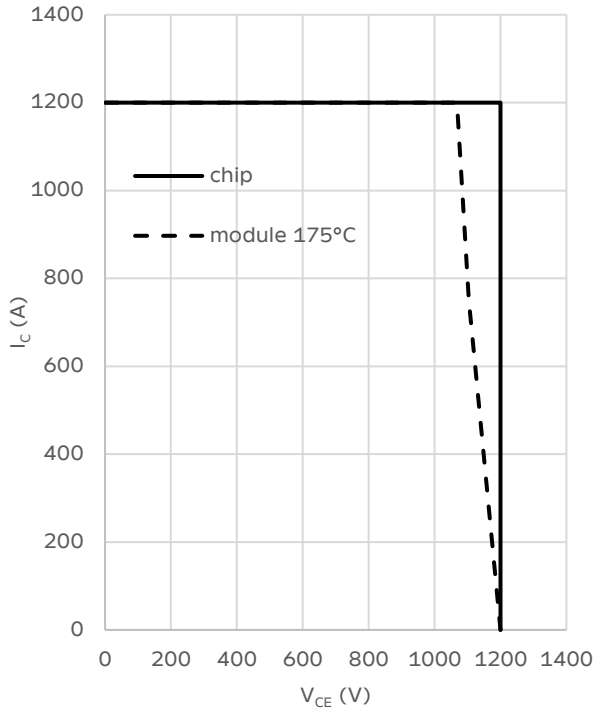


IGBT RBSOA

IGBT 反偏安全工作区域

$I_C = f(V_{CEM})$

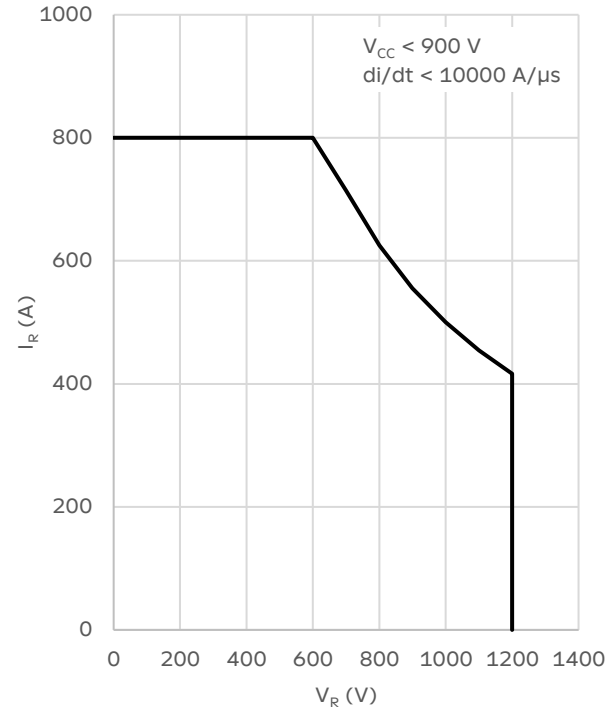
$R_{Goff} = 1.5\ \Omega, V_{GE} = \pm 15\text{ V}$



Diode SOA

Diode 反偏安全工作区域

$T_{vj} \leq 175\text{ }^\circ\text{C}$

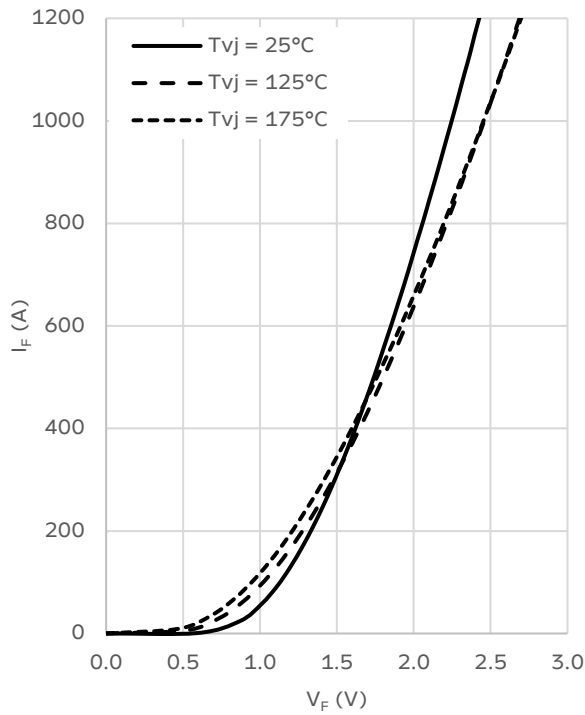




Diode forward characteristic (typical)

二极管正向特性 (典型)

$I_F = f(V_F)$

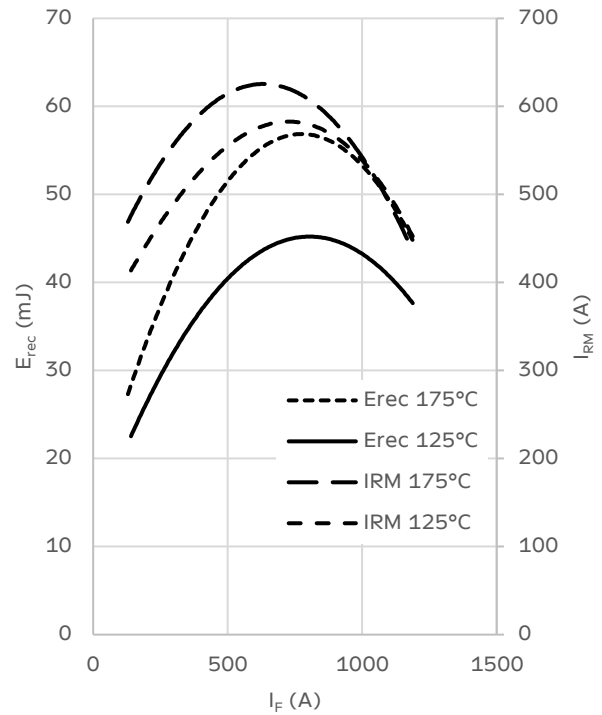


Diode switching characteristics (typical)

二极管开关特性 (典型)

$E_{rec} = f(I_F), I_{RM} = f(I_F)$

$V_{DC} = 600\text{ V}, R_{Gon} = 0.47\ \Omega$ (IGBT), $V_{GE} = -15/+15\text{ V}$ (IGBT)

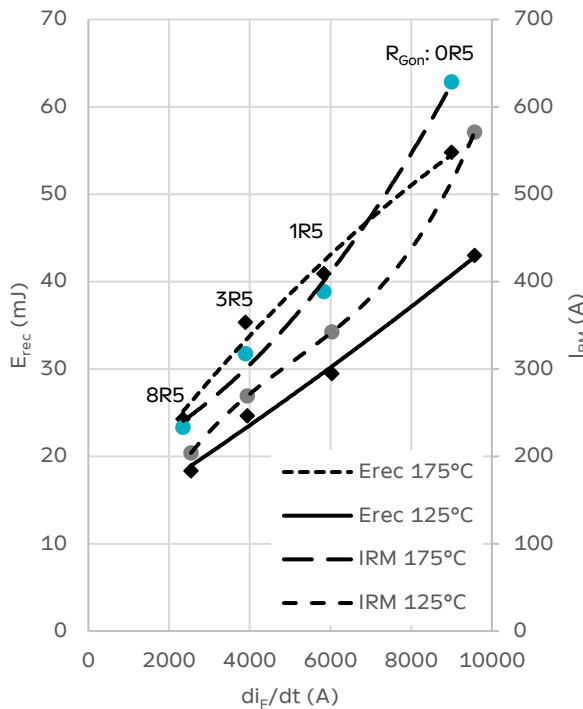


Diode switching characteristics (typical)

二极管开关特性 (典型)

$E_{rec} = f(di/dt), I_{RM} = f(di/dt)$

$V_{DC} = 600\text{ V}, I_F = 600\text{ A}, V_{GE} = -15/+15\text{ V}$ (IGBT)



Thermal impedance

热阻抗 (典型)

$Z_{th(j-c)} = f(t)$

